

**SLOVENSKI STANDARD
oSIST prEN IEC 63541:2025
01-junij-2025**

Kristali litijevega tantalata in litijevega niobata za površinske zvočnovalovne naprave (SAW) - Specifikacije in merilne metode

Lithium tantalate and lithium niobate crystals for surface acoustic wave (SAW) device applications - Specifications and measuring methods

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SECRETARIAT:

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OF INTEREST TO THE FOLLOWING COMMITTEES:

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SUBMITTED FOR CENELEC PARALLEL VOTING

NOT SUBMITTED FOR CENELEC PARALLEL VOTING

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TITLE:

Lithium tantalate and lithium niobate crystals for surface acoustic wave (SAW) device applications - Specifications and measuring methods

PROPOSED STABILITY DATE: 2028

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